

Notice of References Cited		Application/Control No.	Applicant(s)/Patent Under Reexamination	
		10/046,929	MULLEN, PATRICK W.	
Examiner Mark Tsidulko		Art Unit 2875	Page 1 of 1	

U.S. PATENT DOCUMENTS

*		Document Number Country Code-Number-Kind Code	Date MM-YYYY	Name	Classification
	A	US-2002/0145860	10-2002	Lee, Hea-Chun	362/26
	B	US-5,396,350	03-1995	Beeson et al.	349/62
	C	US-2002/0105793	08-2002	Oda et al.	362/31
	D	US-			
	E	US-			
	F	US-			
	G	US-			
	H	US-			
	I	US-			
	J	US-			
	K	US-			
	L	US-			
	M	US-			

FOREIGN PATENT DOCUMENTS

*		Document Number Country Code-Number-Kind Code	Date MM-YYYY	Country	Name	Classification
	N					
	O					
	P					
	Q					
	R					
	S					
	T					

NON-PATENT DOCUMENTS

*		Include as applicable: Author, Title Date, Publisher, Edition or Volume, Pertinent Pages)
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	V	
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